



BCP030C

HIGH EFFICIENCY HETEROJUNCTION POWER FET CHIP (.25μm x 300μm)

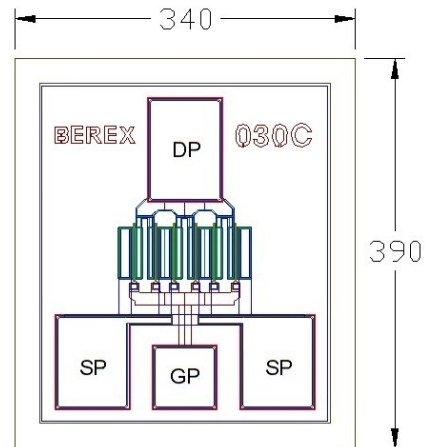
The BeRex BCP030C is a GaAs Power pHEMT with a nominal 0.25-micron by 300-micron gate making this product ideally suited for applications where high-gain and medium power in the DC to 26.5 GHz frequency range are required. The product may be used in either wideband (6-18 GHz) or narrow-band applications. The BCP030C is produced using state of the art metallization with Si₃N₄ passivation and is screened to assure reliability.

PRODUCT FEATURES

- 24.5 dBm Typical Output Power
- 13.5 dB Typical Gain @ 12 GHz
- 0.25 X 300 Micron Recessed Gate

APPLICATIONS

- Commercial
- Military / Hi-Rel.
- Test & Measurement



Chip dimensions : 340 X 390 microns
 Gate pad(GP) : 60 X 60 microns
 Drain pad(DP) : 70 X 100 microns
 Source pad(SP) : 70 X 95 microns
 Chip thickness : 75 microns

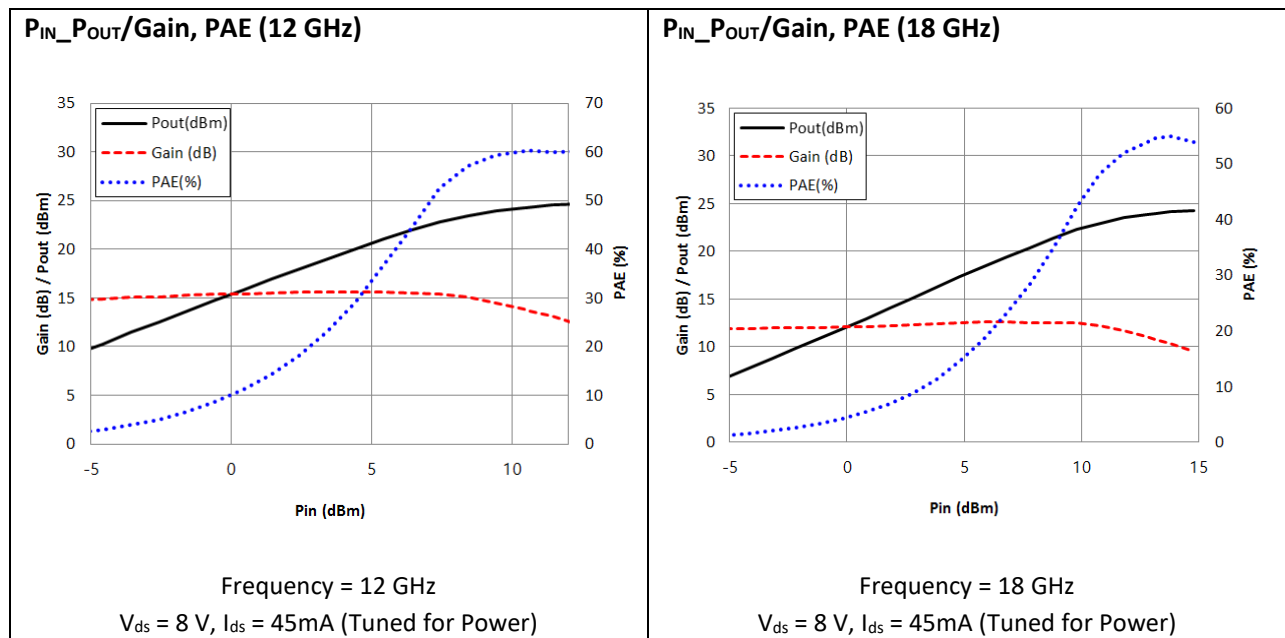
ELECTRICAL CHARACTERISTIC (TUNED FOR POWER) T_a = 25° C

PARAMETER/TEST CONDITIONS		TEST FREQ.	MIN.	TYPICAL	MAX.	UNIT
P _{1dB}	Output Power @ P _{1dB} (V _{ds} = 8V, I _d = 45mA)	12 GHZ 18 GHZ	23.0 23.0	24.5 24.5		dBm
G _{1dB}	Gain @ P _{1dB} (V _{ds} = 8V, I _d = 45mA)	12 GHZ 18 GHZ	12.0 9.0	13.5 10.5		dB
PAE	PAE @ P _{1dB} (V _{ds} = 8V, I _d = 45mA)	12 GHZ 18 GHZ		60 55		%
NF	Noise figure (V _{ds} = 2V, I _d = 15 mA)	12 GHZ		1.1		dB
I _{dss}	Saturated Drain Current (V _{gs} = 0V, V _{ds} = 2.0V)		60	90	120	mA
G _m	Transconductance (V _{ds} = 2V, I _d = 45mA)			115		mS
V _p	Pinch-off Voltage (I _{ds} = 0.3mA, V _{ds} = 2V)		-2.5	-1.2		V
BV _{gd}	Drain Breakdown Voltage (I _g = -0.3mA, source open)			-15	-12	V
BV _{gs}	Source Breakdown Voltage (I _g = -0.3mA, drain open)			-13		V
R _{th}	Thermal Resistance (Au-Sn Eutectic Attach)			115		°C/W

MAXIMUM RATING ($T_a = 25^\circ\text{C}$)

PARAMETERS		ABSOLUTE	CONTINUOUS
V_{ds}	Drain-Source Voltage	12 V	8 V
V_{gs}	Gate-Source Voltage	-6 V	-3 V
I_d	Drain Current	I_{dss}	I_{dss}
I_{gsf}	Forward Gate Current	18 mA	3 mA
P_{in}	Input Power	22 dBm	@ 3 dB compression
T_{ch}	Channel Temperature	175°C	150°C
T_{stg}	Storage Temperature	-60°C – 150°C	-60°C – 150°C
P_t	Total Power Dissipation	1.3 W	1.1 W

Exceeding any of the above Maximum Ratings will result in reduced MTTF and may cause permanent damage to the device.

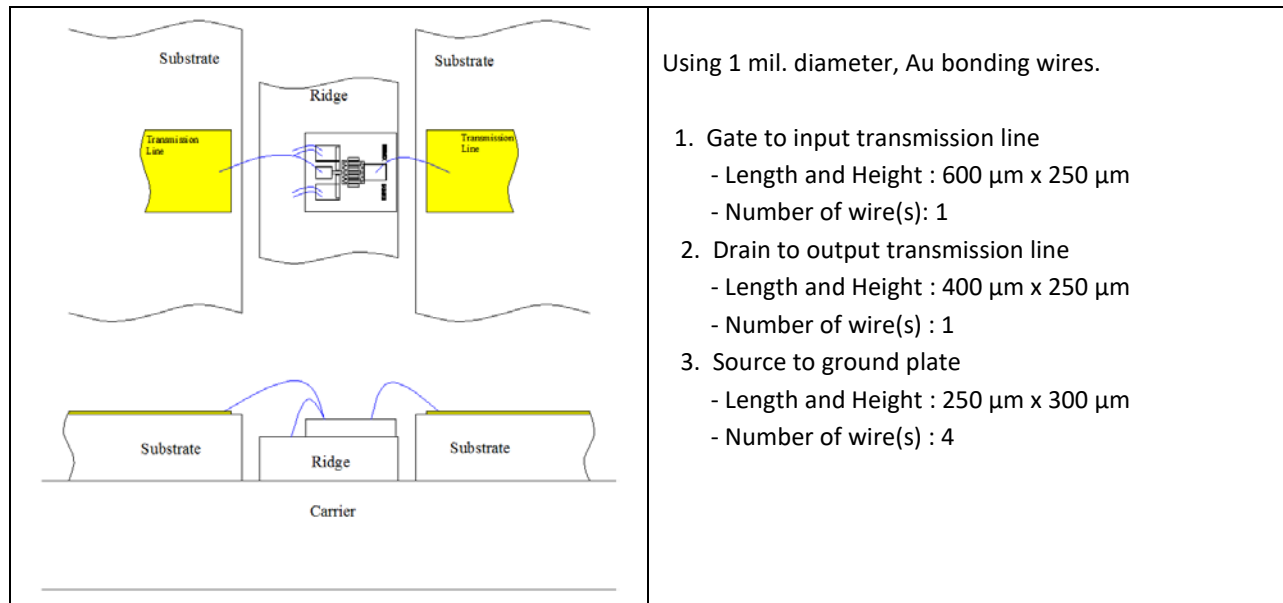


S-PARAMETERS ($V_{ds} = 8V$, $I_{ds} = 45mA$)

FREQ. [GHZ]	S11 [MAG]	S11 [ANG.]	S21 [MAG]	S21 [ANG.]	S12 [MAG]	S12 [ANG.]	S22 [MAG]	S22 [ANG.]
1.0	0.98	-23.86	7.38	162.50	0.014	74.60	0.81	-6.76
2.0	0.94	-46.46	7.02	146.70	0.030	66.16	0.79	-13.54
3.0	0.89	-69.03	6.57	131.52	0.038	55.17	0.75	-19.74
4.0	0.84	-91.85	6.05	117.38	0.046	47.41	0.71	-23.65
5.0	0.79	-113.68	5.52	103.92	0.054	38.46	0.67	-27.78
6.0	0.76	-134.40	4.98	91.19	0.056	30.31	0.63	-31.80
7.0	0.75	-153.92	4.49	79.98	0.057	24.78	0.60	-34.64
8.0	0.74	-170.69	4.01	69.58	0.056	19.61	0.57	-37.56
9.0	0.75	174.28	3.58	59.64	0.056	14.51	0.55	-41.45
10.0	0.76	161.67	3.21	50.90	0.051	10.25	0.53	-44.56
11.0	0.77	150.68	2.88	42.68	0.050	9.53	0.52	-48.73
12.0	0.79	140.76	2.61	34.50	0.049	8.41	0.51	-53.13
13.0	0.81	131.79	2.38	27.20	0.049	6.81	0.49	-57.19
14.0	0.83	124.13	2.16	20.07	0.049	3.22	0.47	-61.62
15.0	0.85	116.58	1.97	12.99	0.046	4.27	0.46	-66.25
16.0	0.86	110.76	1.79	6.68	0.047	5.07	0.44	-71.83
17.0	0.88	106.16	1.66	0.71	0.049	3.61	0.43	-79.17
18.0	0.89	100.57	1.52	-6.23	0.051	1.39	0.42	-86.51
19.0	0.90	96.91	1.39	-12.56	0.051	2.67	0.42	-95.77
20.0	0.91	93.43	1.26	-18.91	0.051	-1.59	0.41	-107.58
21.0	0.90	91.80	1.15	-24.47	0.054	-0.89	0.42	-118.49
22.0	0.90	90.93	1.05	-29.70	0.054	-1.15	0.44	-129.50
23.0	0.89	90.40	0.95	-35.59	0.058	-2.37	0.46	-140.82
24.0	0.90	90.80	0.87	-39.96	0.056	0.12	0.48	-151.10
25.0	0.90	91.15	0.80	-44.03	0.052	-1.19	0.51	-159.63
26.0	0.92	90.01	0.72	-48.59	0.059	1.93	0.55	-168.32

Note: S-parameters include bond wires. Reference planes are at edge of substrates shown on "Wire Bonding Information" figure below.

WIRE BONDING INFORMATION



Proper ESD procedures should be followed when handling this device.

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